

SSCL08N30PN6

N-Channel Enhancement Mode MOSFET

Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	l _D
30V	+20V	0.8 mΩ@10V 252A	2524
	<u> </u>	1.2 mΩ@4.5V	252A

> Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

Applications

- DC/DC converters
- Power supplies
- Motor Drive Control
- Synchronous rectification

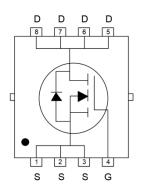
Ordering Information

Device	Package	Shipping
SSCL08N30PN6	PDFN5X6-8L	5000/Reel

> Pin Configuration



PDFN5X6-8L(Top View)



Pin Configuration



Marking

(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V _{DSS}	Drain-to-Source Voltage		30	V
V _{GSS}	Gate-to-Source Volta	Gate-to-Source Voltage		V
	0	T _C =25°C	252	^
ID	Continuous Drain Current d	T _C =100℃	160	A
	Continuous Drain Current ^a	T _A =25℃	38	^
IDSM		T _A =70°C	30	Α
I _{DM}	Pulsed Drain Curren	t ^b	1008	Α
D	Power Dissipation $^{\circ}$ $ T_{\text{C}} = 25^{\circ} \text{C} $ $ T_{\text{C}} = 100^{\circ} \text{C} $	Tc=25°C	125	107
P _D		50	W	
Б	David Divide the s	T _A =25℃	2.8	34/
P _{DSM}	Power Dissipation ^a	T _A =70°C	1.8	W
las	Avalanche Current ^b L=0.5mH Single Pulse		48	Α
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		576	mJ
TJ	Operation junction temperature		-55~150	°C
T _{STG}	Storage temperature range		-55~150	℃

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Max.	Unit
Reja	Junction-to-Ambient Thermal Resistance a	44	55	°C/W
R _{θJC}	Junction-to-Case Thermal Resistance	1.0	1.3	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.0 www.sscsemi.com Analog Future



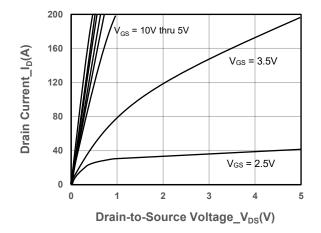
SSCL08N30PN6

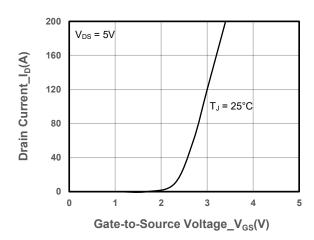
> Electrical Characteristics (T_A=25℃ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250µA	30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250uA$	1.0	1.7	2.5	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 20A		0.8	1.2	mΩ
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = 4.5V, I _D = 10A		1.2	1.6	mΩ
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30V, V _{GS} = 0V			1	μA
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = 5V, I _D = 10A		55		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 10A		0.7	1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		1.0		Ω
Input Capacitance	Ciss	V 45V V 0V		3610		
Output Capacitance	Coss	V _{DS} = 15V, V _{GS} = 0V,		1845		pF
Reverse Transfer Capacitance	Crss	f = 1MHz		112		
Total Gate Charge	Q _G	10//// 45//		55		
Gate to Source Charge	Q _{GS}	V _{GS} = 10V, V _{DS} = 15V,		10		nC
Gate to Drain Charge	Q _{GD}	- I _D = 20A		8		
Turn-on Delay Time	T _{D(ON)}			7		
Rise Time	Tr	V _{GS} = 10V, V _{DS} = 15V,		16		
Turn-off Delay Time	T _{D(OFF)}	$I_D = 20A, R_G = 3\Omega$		35		ns
Fall Time	T _f			16		
Diode Recovery Time	Trr	I _F =20A, di/dt=100A/us		43		ns
Diode Recovery Charge	Q _{rr}	I _F =20A, di/dt=100A/us		42		nC



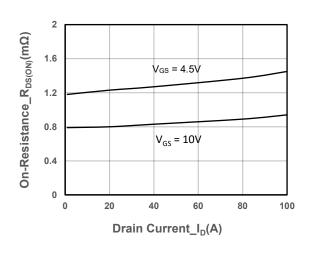
> Typical Performance Characteristics (T_A=25℃ unless otherwise noted)

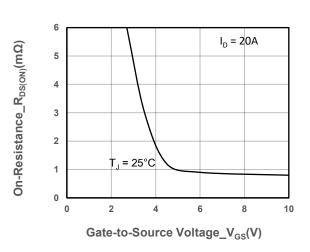




Output Characteristics

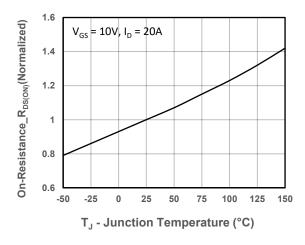


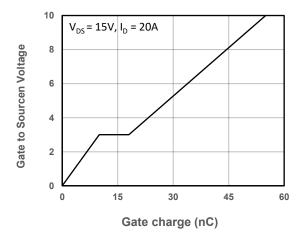




On-Resistance vs. Drain Current and Gate Voltage

On-Resistance vs. Gate-to-Source Voltage



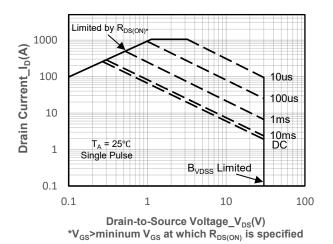


On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge

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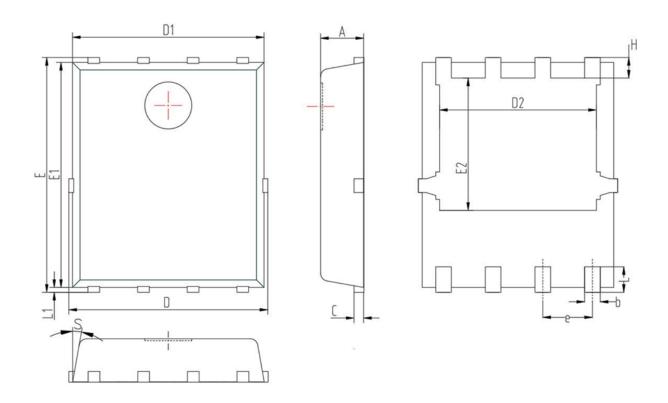




Safe Operating Area vs. Junction-to-Ambient



Package Information



Symbol	MILL IMETER			
	Min	Nom	Max	
А	0.90	1.05	1.20	
b	0.25	0.30	0.51	
С	0.15	0.25	0.35	
D	4.80	5.10	5.40	
D1	4.80	5.00	5.20	
D2	3.70	4.00	4.30	
E	5.80	6.15	6.50	
E1	5.50	5.75	5.95	
E2	3.30	3.45	3.67	
е	1.27BSC			
Н	0.40	0.60	0.93	
L	0.45	0.65	0.85	
L1	0.00	0.10	0.25	
S	0°		12°	



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